

Radiation protection instrumentation — In vivo counters — Classification, general requirements and test procedures for portable, transportable and installed equipment

The European Standard EN 61582:2006 has the status of a
British Standard

ICS 13.280

National foreword

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Summary of pages

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This British Standard was published under the authority of the Standards Policy and Strategy Committee on 30 June 2006

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ISBN 0 580 48479 3

Amendments issued since publication

Amd. No.	Date	Comments